



Product data sheet

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PIN2 D

PIN3 S

N-Channel MOSFET

Description

The AOD424-MS uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features $V_{DS} = 20V I_D = 60 A$ $R_{DS(ON)} < 6.5m\Omega @ V_{GS} = 4.5V$

Application

Battery protection Load switch Uninterruptible power supply



PIN1 G

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vds	20	V
Gate-Source Voltage	Vgs	±12	V
Drain Current-Continuous	١D	60	А
Drain Current-Continuous(T _C =100℃)	I _D (100℃)	42	А
Pulsed Drain Current	Ідм	210	А
Maximum Power Dissipation	PD	60	W
Derating factor		0.48	W/℃
Single pulse avalanche energy (Note 5)	Eas	200	mJ
Operating Junction and Storage Temperature Range	Тј,Тѕтб	-55 To 150	°C
Thermal Resistance, Junction-to-Case ^(Note 2)	Rejc	2.1	°C /W



AOD424-MS HF Semiconductor Compiance

Electrical Characteristics (Tc=25 $^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Мах	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	20	-	-	V
Zero Gate Voltage Drain Current	IDSS	V _{DS} =20V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	lgss	V _{GS} =±12V,V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250µA	0.5	0.75	1.0	V
Drain-Source On-State Resistance		V _{GS} =4.5V, I _D =20 A	-	5.5	7	mΩ
	RDS(ON)	V _{GS} =2.5V, I _D =15A		6.2	9	mΩ
Forward Transconductance	g fs	V _{DS} =10V,I _D =20A	15	-	-	S
Input Capacitance	Clss		-	2000	-	PF
Output Capacitance	Coss	V _{DS} =10V,V _{GS} =0V,	-	500	-	PF
Reverse Transfer Capacitance	Crss	F=1.0MHz	-	200	-	PF
Turn-on Delay Time	td(on)		-	6.4	-	nS
Turn-on Rise Time	tr	V _{DD} =10V,I _D =2A,R _L =1Ω	-	17.2	-	nS
Turn-Off Delay Time	td(off)	V_{GS} =4.5V, R_{G} =3 Ω	-	29.6	-	nS
Turn-Off Fall Time	t _f		-	16.8	-	nS
Total Gate Charge	Qg		-	27		nC
Gate-Source Charge	Qgs	V _{DS} =10V,I _D =20A,	-	6.5		nC
Gate-Drain Charge	Q _{gd}	V _{GS} =10V	-	6.4		nC
Diode Forward Voltage (Note 3)	Vsd	V _{GS} =0V,I _S =10A	-		1.2	V
Diode Forward Current (Note 2)	ls		-	-	60	А
Reverse Recovery Time	trr	TJ = 25°C, IF = 20A	-	25	-	nS
Reverse Recovery Charge	Qrr	di/dt = 100A/ μ s ^(Note3)	-	24	-	nC
Forward Turn-On Time	ton	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. Surface Mounted on FR4 Board, $t \le 10$ sec.

3. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%.

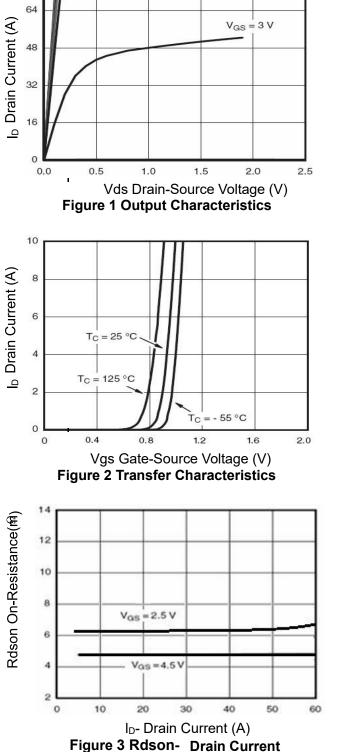
4. Guaranteed by design, not subject to production

5. Eas condition : Tj=25 $^\circ \!\! C$,V_DD=10V,V_G=10V,L=0.5mH,Rg=25\Omega,

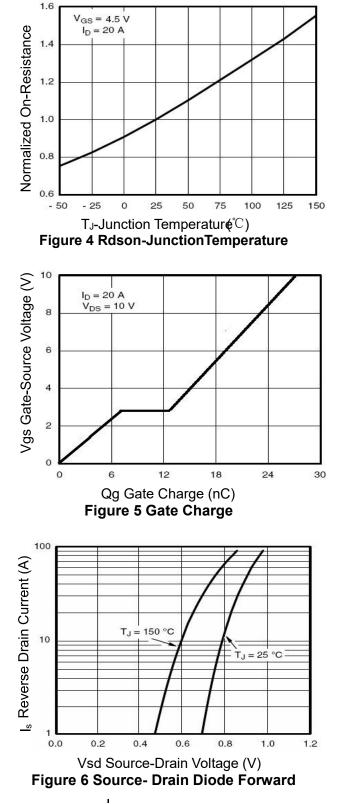






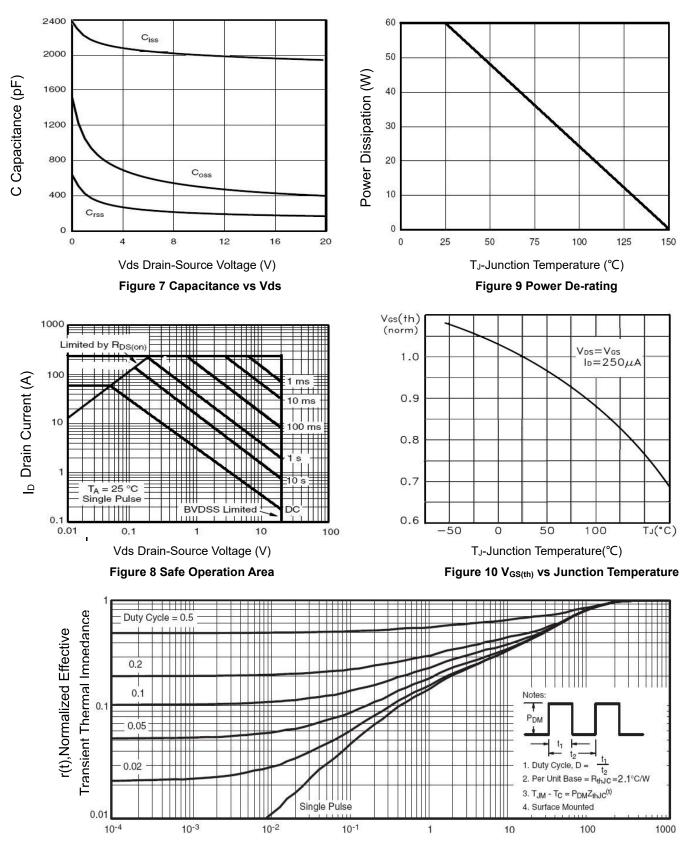


Typical Electrical and Thermal Characteristics (Curves)







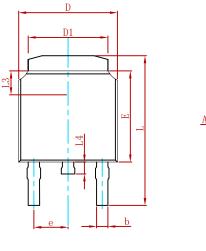


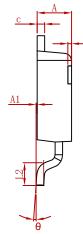
Square Wave Pluse Duration(sec) Figure 11 Normalized Maximum Transient Thermal Impedance



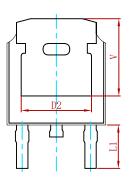


PACKAGE MECHANICAL DATA



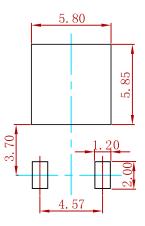


h



Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.635	0.770	0.025	0.030	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830 REF.		0.190 REF.		
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.712	10.312	0.382	0.406	
L1	2.900 REF.		0.114 REF.		
L2	1.400	1.700	0.055	0.067	
L3	1.600 REF.		0.063 REF.		
L4	0.600	1.000	0.024	0.039	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.250 REF.		0.207	REF.	

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.

3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AOD424-MS	TO-252	2500





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